

L Number	Hits	Search Text	DB	Time stamp
-	6	("3752952" "3409799").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 12:52
-	18	"3752952" "3409799"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 13:05
-	1272	electron adj beam and (beam near4 profile)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 14:05
-	553	(electron adj beam and (beam near4 profile)) and (target or reticle)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 13:07
-	31	((electron adj beam and (beam near4 profile)) and (target or reticle)) and back adj scatter\$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 14:05
-	48	(electron adj beam and (beam near4 profile)) and back adj scatter\$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 21:25
-	29	(electron adj beam and test adj pattern) and back adj scatter\$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 19:18

-	14612	electron adj beam and weld\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 21:25
-	90	electron adj beam and weld\$3 and backscatter\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 14:33
-	19	(electron adj beam and weld\$3 and backscatter\$3) and spot adj (size or shape)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:42
-	90	(electron adj beam) and weld\$3 and backscatter\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 14:33
-	0	(electron adj beam and weld\$3 and backscatter\$3) and spot adj (profile or uniformity)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 14:42
-	2	(electron adj beam and weld\$3 and backscatter\$3) and beam adj (profile or uniformity)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 16:08
-	911	electron adj beam and test adj pattern	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:33
-	23	(electron adj microscope and test adj pattern) and back adj scatter\$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 18:50

-	2996	(electron adj microscope and slit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 19:26
-	59	(electron adj microscope and slit) and beam adj profile	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/27 19:32
-	4	(electron adj microscope and slit) and (electron near4 beam adj profile)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:24
-	10030	(electron adj microscope and (needle or raised))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:26
-	3778	(electron adj microscope and (needle ))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:27
-	72	(electron adj microscope and (needle near4 tungsten ))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:27
-	56	(electron adj microscope and (needle near2 tungsten ))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:28
-	0	electron adj beam and ( test adj pattern) near4 needle	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:34

-	0	electron adj beam and ( test adj pattern) near4 raised	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:35
-	12080	electron adj beam and grid	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:35
-	1707	electron adj beam and grid and distortion	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 14:35
-	16	electron adj beam and grid and distortion near measurement	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 17:16
-	17	"6204509"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 17:02
-	64	electron adj beam and grid and distortion WITH measurement	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/28 17:17
-	16	(electron adj beam and weld\$3 and backscatter\$3) and image and target	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 15:51
-	31	(electron adj beam and weld\$3 and backscatter\$3) and image	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 15:57

-	6	(electron adj beam and machining and backscatter\$3) and beam adj (profile or uniformity)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 16:38
-	0	electron adj beam WITH milling and back-scattered	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 16:14
-	13	(electron adj beam WITH milling) and backscattered	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 16:34
-	5087	(electron adj beam )and beam near control\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 16:35
-	10367	(electron adj beam )and beam near2 control\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 16:36
-	3751	(electron adj beam )and beam adj control\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 16:36
-	2043	(electron adj beam ) and beam adj control	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 16:36
-	0	((electron adj beam and weld\$3 and backscatter\$3) and image) and ((electron adj beam ) and beam adj control)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:19

-	362	electron adj beam WITH milling	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 16:57
-	71	(electron adj beam WITH milling) and (backscattered or secondary)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 17:05
-	36	(electron adj beam WITH milling) and (backscattered or secondary) and measur\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 17:28
-	14	(electron adj beam WITH repair) and (backscattered or secondary) and measur\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/07 17:28
-	2354	((electron adj beam and weld\$3 ) and image)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:20
-	71	((((electron adj beam and weld\$3 ) and image) ) and segmented	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:28
-	1	((((electron adj beam and weld\$3 ) and image) ) and sensor adj ring	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:31
-	21	((((electron adj beam and weld\$3 ) and image) ) and sensor WITH ring	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:31



-	1	(US-3409799-\$ or US-3409799-\$).did.	USOCR	2004/10/11 15:37
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-	29	((US-6524873-\$ or US-6566885-\$ or US-6576923-\$ or US-6603120-\$ or US-6633174-\$ or US-6636064-\$ or US-6670602-\$ or US-6749346-\$ or US-6771806-\$ or US-6770883-\$ or US-6734611-\$ or US-6268118-\$ or US-6204509-\$ or US-6787780-\$ or US-6008800-\$ or US-5982352-\$ or US-6703624-\$ or US-6591658-\$ or US-6375768-\$ or US-6180570-\$ or US-6354133-\$ or US-5374826-\$ or US-5051600-\$ or US-3798453-\$ or US-6326619-\$ or US-4950940-\$).did. or (US-5043583-\$ or US-4794259-\$ or US-4908545-\$ or US-4178529-\$ or US-4179604-\$ or US-4178528-\$ or US-5077774-\$ or US-6700127-\$ or US-6670610-\$ or US-5900667-\$ or US-4999234-\$ or US-4888260-\$ or US-4874213-\$ or US-4839250-\$ or US-4301237-\$ or US-4260670-\$ or US-6542576-\$ or US-6180289-\$ or US-6171736-\$ or US-6114695-\$ or US-5986765-\$ or US-5969357-\$ or US-5888682-\$ or US-5866904-\$ or US-5554926-\$ or US-5594245-\$ or US-5468966-\$).did. or (US-5382895-\$ or US-6563591-\$ or US-6377657-\$ or US-6399258-\$ or US-6317216-\$ or US-6303931-\$ or US-6174801-\$ or US-5825040-\$ or US-4634645-\$ or US-5759423-\$ or US-6714620-\$ or US-6617587-\$ or US-6203952-\$ or US-6593152-\$ or US-6333510-\$ or US-5969365-\$ or US-6242751-\$ or US-5757015-\$ or US-6107637-\$ or US-5414330-\$ or US-4774460-\$ or US-4989072-\$ or US-6429440-\$ or US-6417516-\$ or US-3816848-\$ or US-3673412-\$ or US-3937959-\$).did. or (US-3875585-\$ or US-4325082-\$ or US-4587464-\$ or US-4400609-\$ or US-4654506-\$ or US-4929836-\$ or US-6333968-\$ or US-3752952-\$ or US-3602765-\$ or US-6636311-\$ or US-6753518-\$ or US-6489091-\$ or US-5216631-\$ or US-5307311-\$ or US-5647883-\$ or US-5616921-\$ or US-4316093-\$ or US-4299911-\$ or US-4197332-\$ or US-6753538-\$ or US-4906326-\$ or US-4979223-\$ or US-6514289-\$ or US-6424697-\$ or US-6459090-\$ or US-6534222-\$ or US-3633065-\$).did. or (US-5825033-\$ or US-5158491-\$ or US-3666985-\$ or US-6787783-\$ or US-6661009-\$ or US-6537310-\$ or US-6507044-\$ or US-5846447-\$ or US-5821556-\$ or US-5770309-\$ or US-5674307-\$ or US-5960058-\$ or US-5978085-\$ or US-5878108-\$ or US-5798947-\$ or US-6091187-\$ or US-5011755-\$ or US-6166380-\$ or US-5360764-\$ or US-5130539-\$ or US-3644700-\$ or US-6445199-\$ or US-6509197-\$ or US-6184160-\$ or US-6321114-\$ or US-6445948-\$ or US-6459566-\$).did. or (US-6493212-\$ or US-5241185-\$ or US-5751004-\$ or US-5907425-\$ or US-6007208-\$ or US-6088145-\$ or US-6154305-\$ or US-6433561-\$ or US-6099600-\$ or US-6141205-\$ or US-6157531-\$ or US-6212063-\$ or US-6009348-\$ or US-6118652-\$ or US-6042624-\$ or US-6006133-\$ or US-6032075-\$).did. or (US-20030032039-\$ or US-20030038579-\$ or US-20010028046-\$ or US-20030189180-\$ or US-20010028043-\$ or US-20010028044-\$ or US-20010028038-\$ or US-20010028042-\$ or US-20040197471-\$ or US-20040173747-\$ or US-20040046131-\$ or US-20030222221-\$ or US-20030132196-\$ or
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-	750	weld near4 image	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:42
-	30	weld near4 image and electron adj beam	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:43
-	5	weld near4 image and electron adj beam and segment\$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:43
-	2	(electron adj microscope and test adj pattern) and usaf	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:55
-	25	(electron adj microscope ) and usaf	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 15:59
-	195	segmented adj detector	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 16:00
-	25	segmented adj detector and electron adj beam	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 16:00
-	5	"4794259"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 21:23

-	3129	(250/397 250/398 250/307 216/39).cccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 21:24
-	14	((250/397 250/398 250/307 216/39).cccls.) and (electron adj beam and (beam near4 profile)) and back adj scatter\$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 21:25
-	68	((250/397 250/398 250/307 216/39).cccls.) and electron adj beam and weld\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 21:26
-	35	((250/397 250/398 250/307 216/39).cccls.) and electron adj beam and weld\$3) and image	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/11 21:26